## Supplementary Information for:

## Metallized SU-8 thin film patterns on stretchable PDMS

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1. Shadow and photo masks used for the study

Supplementary Figure S1 shows shadow and photo masks used in the study.


Supplementary Figure S1. Photographs of the shadow masks and photomasks used in the study. (a) 'Mask 1', (b) 'Mask 2', and (c) 'Mask 3' are shadow masks for process 1 described in the article. (d) and (e) are photomasks employed for process 2 described in the article.

## 2. Samples which resulted in wrinkling of the SU-8 film

### 2.1 Experimental results

Supplementary Figure S2 shows process-induced wrinkling in the SU-8 skin on PDMS.


Supplementary Figure S2. Process-induced wrinkling of the SU-8 film on PDMS. (a) Scanning electron microscopy (SEM) image of wrinkles in a lithographically patterned 800 nm thick SU-8 skin on PDMS. (b) Optical interference surface profiler characterization of the wrinkles. (c) and (d) shows profiles of wrinkles. (c) and (d) present the frequency and the amplitude of wrinkles respectively.

Supplementary Figure S2(a) shows a scanning electron microscopy (SEM) image of the wrinkling of the SU-8 skin. This is due to thermally-induced compressive stress. The period and amplitude of the wrinkling was measured using a 3D optical interference surface profiler-see Supplementary Figure S2(bd). In general, the wrinkling was perpendicular to the longest lengths of the SU-8 lines. The period of the
wrinkling $\lambda$ was measured to be $49.5 \mu \mathrm{~m}$ and its amplitude was $2.4 \mu \mathrm{~m}$. This is in contrast to the wrinkling which could be observed in larger surface SU-8 skins-see Supplementary Figure S3-where the wrinkles are more randomly orientated.

### 2.2 Large area surfaces



Supplementary Figure S3. Optical microscopy at different zooms (a-c) showing wrinkling of the metallized SU-8 films on PDMS. See scale bars for dimensions.

### 2.3 Modelling of the wrinkles

In the absence of an externally applied strain the total stress $\sigma_{t o t}$ in the $\mathrm{SU}-8$ film is the intrinsic stress $\sigma_{i n t}$ (due to e.g. solvent loss and molecular cross linking during polymerization) plus the extrinsic stress $\sigma_{t h}$ (due to thermal expansion).

The in plane extrinsic stress $\sigma_{t h}$ in the $\mathrm{SU}-8$ is given by:

$$
\begin{equation*}
\sigma_{t h}=\alpha_{S U-8}-\alpha_{P D M S} \frac{E_{S U-8}}{1-v_{S U-8}}\left(T_{P E B}-T_{0}\right) \tag{1}
\end{equation*}
$$

where $\alpha_{S U-8}$ and $\alpha_{P D M S}$ are the linear expansion coefficients of the SU-8 and PDMS (remembering that $\left.\alpha_{L}=C T E / 3\right), E_{S U-8}$ and $v_{S U-8}$ are the elastic modulus and Poisson coefficient of the SU-8, and $T_{P E B}$ and $T_{0}$ are the post exposure bake (PEB) and ambient temperatures.

The critical compressive stress $\sigma_{\text {crit }}$ for wrinkling in the SU-8 film is given by:

$$
\begin{equation*}
\sigma_{\text {crit }}=0.52\left(\frac{E_{S U-8}}{1-v_{S U-8}^{2}}\right)^{\frac{1}{3}}\left(\frac{E_{P D M S}}{1-v_{P D M S}^{2}}\right)^{\frac{2}{3}} \tag{2}
\end{equation*}
$$

Where $E_{P D M S}$ and $v_{P D M S}$ are the elastic modulus and Poisson coefficient of the PDMS.

The period of the wrinkles $\lambda_{S U-8}$ in the SU-8 film is given by:

$$
\begin{equation*}
\lambda_{S U-8}=2 \pi t_{S U-8}\left(\frac{E_{S U-8}\left(1-v_{P D M S}^{2}\right)}{3 E_{P D M S}\left(1-v_{S U-8}^{2}\right)}\right)^{\frac{1}{3}} \tag{3}
\end{equation*}
$$

Where $t_{S U-8}$ is the thickness of the SU-8 film.

If we assume that $\sigma_{\text {th }} \gg \sigma_{\text {int }}$ as the PDMS has a large thermal expansion coefficient then given the physical properties give in the table below, a thickness of SU-8 equal to 800 nm and a $\mathrm{PEB}=95^{\circ} \mathrm{C}$ we can evaluate the in plane stress in the $\mathrm{SU}-8$ to be -64 MPa -i.e. the $\mathrm{SU}-8$ is in compression. The critical compressive stress required for wrinkling of the $\mathrm{SU}-8$ film is computed to be -15.7 MPa . As $\sigma_{\text {crit }}<\sigma_{\text {tot }}$ wrinkling is predicted having a period $\lambda_{S U-8}$ of $35.7 \mu \mathrm{~m}$. This value agrees relatively well with the experimental values given above.

| Physical property | Value |
| ---: | :--- |
| $\boldsymbol{C T E} E_{S U-8}$ | $5.2 \times 10^{-5}{ }^{\circ} \mathrm{C}^{-1}$ |
| $\boldsymbol{C T E} \boldsymbol{E}_{P D M S}$ | $9.6 \times 10^{-4}{ }^{\circ} \mathrm{C}^{-1}$ |


| $\boldsymbol{E}_{\boldsymbol{S U - 8}}$ | $1.7-2.2 \mathrm{GPa}$ |
| :--- | :--- |
| $\boldsymbol{u} \boldsymbol{t} \boldsymbol{s}_{\boldsymbol{S U}=\mathbf{8}}$ | $34-130 \mathrm{MPa}$ |
| $\boldsymbol{E}_{\boldsymbol{P D M S}}$ | 2.6 MPa |
| $\boldsymbol{v}_{\boldsymbol{S U}=\mathbf{8}}$ | 0.22 |
| $\boldsymbol{v}_{\boldsymbol{P D M S}}$ | 0.5 |
| $\boldsymbol{T}_{\boldsymbol{P E B},}, \boldsymbol{T}_{\mathbf{0}}$ | $95^{\circ} \mathrm{C}, 20^{\circ} \mathrm{C}$ |

Supplementary Table S1: Physical properties of the SU-8 and the PDMS for the process and conditions used in the study. Mechanical properties of SU-8 [1-4]. Mechanical properties of PDMS [5]. CTE of SU-8 [6]. CTE of PDMS data sheet for Sylgard 184 (Dow Corning, USA).

## 3. Modelling of the line cracking as the line orientation angle is changed

Supplementary Figure S4 shows an idealized sample containing a single metallized SU-8 line on a PDMS block. The line is orientated at an angle $\theta$ relative to the longitudinal direction of the applied global strain (vertical direction on the figure).


Supplementary Figure S4 Modelling of the metallized SU-8 skin on PDMS. (a) A single thin film Au/Ti/SU8 line is shown on a thick rectangular PDMS support (light blue). (b) The line is orientated at an angle $\theta$ relative to the sample bottom edge. We can define an effective length $l_{\text {eff }}$ (blue) and an effective width $w_{\text {eff }}$ (red) parallel and perpendicular to the longitudinal direction of the applied strain. (c) The
equivalent straight line to that presented in (b) having dimensions $l_{\text {eff }}$ and $w_{\text {eff }}$. (d) Effect of global straining and the associated Poisson effect on the sample. The total in-line stress in the line $\sigma_{l}$ (green arrow) is given by the difference of the components of $\sigma_{x}$ and $\sigma_{y}$ projected onto the direction of the line. (e) The Hookean spring-based model of the sample. The model separates the PDMS into three parts: two series PDMS1 portions (light blue) and a PDMS2 portion (light red) which is in parallel with the Au/Ti/SU8 line (gold).

The sample shown in Supplementary Information Figure S4(a) can be divided up into 3 distinct portions. First, the lines are composed of an $\mathrm{Au} / \mathrm{Ti} / \mathrm{SU}-8$ thin film multi-layer. The lines have a length $l$ and a width $w$. For a given orientation angle $\theta$, the line has an effective length $l_{\text {eff }}$ and an effective width $w_{\text {eff }}$. The thicknesses of the gold, the titanium, and the SU-8 are $t_{A u}, t_{T i}$, and $t_{S U-8}$. Second, the PDMS portions in series with the lines-these are referred to as PDMS1 (light blue). Third, the PDMS portion in parallel with the lines-this is referred to as PDMS2 (light red). The PDMS block has a length of $l_{0}$, a width $w_{P D M S}$, and a thickness $t_{P D M S}$. The model assumes a linear-elastic-or Hookean-response to strain, and considers only a single line on the substrate surface.

With reference to Supplementary Figure S4(b), the effective length of the equivalent straight line can be approximated by the following formulae:

$$
\begin{align*}
& l_{e f f}=\frac{w}{\cos \theta}  \tag{4}\\
& w_{e f f}=\frac{w}{\sin \theta} \tag{5}
\end{align*}
$$

The above equations are only valid within certain limits. At angles approaching $90^{\circ}$, if $l_{\text {eff }}>l$ then $l_{\text {eff }}$ is set to $l$. At small angles, if $w_{\text {eff }}>l$ then $w_{\text {eff }}$ is set to $l$. These dimensions form a sample having an equivalent line shown in to Supplementary Figure S4(c).

Let us first consider the $y$ direction. With reference to Supplementary Figure $\mathrm{S} 4(\mathrm{~d})$, the mechanical strains in series (the PDMS1 portions and the effective line/PDMS2 portion) add up to give the total strain:

$$
\begin{equation*}
\Delta l_{0}=2 \Delta l_{P D M S 1}+\Delta l_{e f f} \tag{6}
\end{equation*}
$$

The mechanical forces in the central parallel portion (the line plus the PDMS2 portion) add up to give the total force:

$$
\begin{gather*}
F_{y}=\sigma_{y} t_{t o t a l}=F_{P D M S 2}+F_{S U-8}+F_{T i}+F_{A u}  \tag{7}\\
\sigma_{y}=\frac{1}{t_{\text {total }}}\left(E_{P D M S 2} t_{P D M S 2}+E_{S U-8} t_{S U-8}+E_{T i} t_{T i}+E_{A u} t_{A u}\right) \frac{\Delta l_{e f f}}{l_{\text {eff }}} \tag{8}
\end{gather*}
$$

The mechanical strains in parallel are equal:

$$
\begin{equation*}
\Delta l_{P D M S 2}=\Delta l_{S U-8}=\Delta l_{T i}=\Delta l_{A u}=\Delta l_{e f f} \tag{9}
\end{equation*}
$$

The sum of the forces in the individual layers of the effective parallel portions (light red and gold in Fig. 7) are equal to the forces in the two series PDMS1 layers-therefore we can write down:

$$
\begin{equation*}
\frac{\Delta l_{e f f}}{l_{e f f}} \sum t_{n} E_{n}=t_{P D M S 1} E_{P D M S 1} \frac{\Delta l_{P D M S 1}}{l_{P D M S 1}} \tag{10}
\end{equation*}
$$

The extension in one of the series PDMS1 portions is equal to:

$$
\begin{equation*}
\Delta l_{P D M S 1}=\frac{\Delta l_{0}-\Delta l_{e f f}}{2} \tag{11}
\end{equation*}
$$

Therefore the extension in the line plus PDMS2 portion $\Delta l_{\text {eff }}$ is equal to:

$$
\begin{equation*}
\Delta l_{e f f}=\frac{\alpha_{y}}{\alpha_{y}+\beta_{y}} \Delta l_{0} \tag{12}
\end{equation*}
$$

Where:

$$
\begin{align*}
& \alpha_{y}=\frac{t_{P D M S_{1} E_{P D M S 1}}}{2 l_{P D M S 1}}  \tag{13}\\
& \beta_{y}=\frac{\sum t_{n} E_{n}}{l_{e f f}} \tag{14}
\end{align*}
$$

Therefore the longitudinal mechanical stress in the SU-8 layer is given by:

$$
\begin{equation*}
\sigma_{y}^{S U-8}=E_{S U-8} \frac{\Delta l_{e f f}}{l_{e f f}} \tag{15}
\end{equation*}
$$

Or, in terms for total extension $\Delta l_{0}$ :

$$
\begin{equation*}
\sigma_{y}^{S U-8}=\frac{\alpha_{y}}{\left(\alpha_{y}+\beta_{y}\right)} \frac{E_{S U-8}}{l_{e f f}} \Delta l_{0} \tag{16}
\end{equation*}
$$

Let us now consider the $x$ direction. We can use the above arguments to calculate the transversal mechanical stress in the SU-8 line $\sigma_{x}^{S U-8}$. In order to do this, the same equations are used but with modified dimensions where the longitudinal dimensions become the transversal dimensions. We can thus write down an expression for $\sigma_{x}^{S U-8}$ :

$$
\begin{equation*}
\sigma_{x}^{S U-8}=\frac{\alpha_{x}}{\left(\alpha_{x}+\beta_{x}\right)} \frac{E_{S U-8}}{w_{e f f}} \Delta w_{0} \tag{17}
\end{equation*}
$$

where:

$$
\begin{equation*}
\Delta w_{0} \sim v_{P D M S} \Delta l_{0} \tag{18}
\end{equation*}
$$

We can now calculate the in-line stress $\sigma_{l}^{S U-8}$ in the SU-8 in the direction of the line which takes into account the orientation angle and the Poisson effect by using the following relationship:

$$
\begin{equation*}
\sigma_{l}^{S U-8}=\sigma_{y}^{S U-8} \sin \theta-\sigma_{x}^{S U-8} \cos \theta \tag{19}
\end{equation*}
$$

These components are indicated in Supplementary Information Figure S4(d). Equations (16), (17), and (18) can now be injected into Equation (19) in order to plot the in-line stress as a function of applied strain $\Delta l_{0} / l_{0}$ for various line angles $\theta$. This is shown as a contour plot in Fig. 7 of the article.

It is apparent from Equation (19) that for a given line angle the in-line stress will be zero due to compensation of the applied longitudinal stress by the lateral compressive stress due to the Poisson effect. From Equation (19) if $\sigma_{l}^{S U-8}=0$ we have:

$$
\begin{equation*}
\tan \theta=\frac{\sigma_{X}^{S U-8}}{\sigma_{y}^{S U-8}} \tag{20}
\end{equation*}
$$

from Equations (15), (16), and (17) we have:

$$
\begin{equation*}
\frac{\sigma_{x}^{S U-8}}{\sigma_{y}^{S U-8}} \sim v_{P D M S} \tag{21}
\end{equation*}
$$

we have:

$$
\begin{equation*}
\theta=\tan ^{-1} v_{P D M S} \tag{22}
\end{equation*}
$$

## 4. Applied strain versus average interline strain for the samples tested.

Supplementary Figure S5 shows plots of the average interline strain versus the applied strain. The measurement and calculation of the average interline strain is described in the article.


Supplementary Figure S5. Average interline strain plotted as a function of applied strain for 3 types of samples fabricated using 3 types of masking-See Section 1 'Shadow and photo masks used for the study' above. The black dashed line corresponds to a 1:1 plot.

## 5. Behaviour of metallized SU-8 'horseshoe shaped' lines fabricated using photolithography

### 5.1 Cracking in horseshoe shaped lines



Supplementary Figure S6. Optical microscopy images showing horseshoe lines with different widths. These metallized/SU-8 lines on PDMS were fabricated using a photomask. Regular cracking is observed/

Supplementary Figure S6 shows the lithographically patterned horseshoe shaped lines. It was observed that these lines cracked at relatively low longitudinal strains $\left(\sim 5^{\circ}\right)$. We observed that the cracking is relatively ordered, always occurring at the same places in the line. The cracking occurs as there is a large length of line in longitudinal direction of the applied strain. Contrast this to the transversally-orientated lines and the angled line study presented in the manuscript. The authors suggest that the 'amplitude' of such lines should be minimised whilst the period increased.

## References

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